

# HAF1004(L), HAF1004(S)

# Silicon P Channel MOS FET Series Power Switching

REJ03G0028-0500Z (Previous ADE-208-629B (Z)) Rev.5.00 2003.04.29

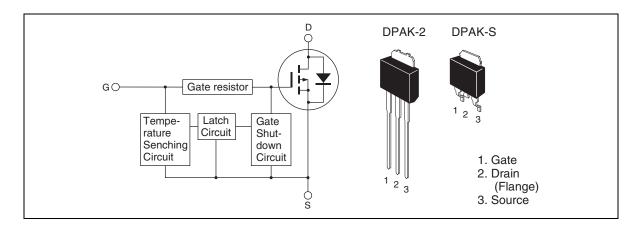
### **Description**

This FET has the over temperature shut-down capability sensing to the junction temperature. This FET has the built-in over temperature shut-down circuit in the gate area. And this circuit operation to shut-down the gate voltage in case of high junction temperature like applying over power consumption, over current etc..

#### **Features**

- Logic level operation to (-4 to -6 V Gate drive)
- High endurance capability against to the shut-down circuit
- Built-in the over temperature shut-down circuit
- Latch type shut down operation (need 0 voltage recovery)

#### **Outline**



# **Absolute Maximum Ratings**

 $(Ta = 25^{\circ}C)$ 

Item	Symbol	Ratings	Unit
Drain to source voltage	$V_{DSS}$	-60	V
Gate to source voltage	V <sub>GSS</sub>	-16	V
Gate to source voltage	V <sub>GSS</sub>	2.5	V
Drain current	I <sub>D</sub>	<b>-</b> 5	A
Drain peak current	I <sub>D (pulse)</sub> Note1	-10	A
Body-drain diode reverse drain current	$I_{DR}$	<b>–</b> 5	A
Cannel dissipation	Pch Note2	20	W
Cannel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Notes: 1. PW  $\leq 0\mu s$ , duty cycle  $\leq 1\%$ 

2. Value at Ta = 25°C

# **Typical Operation Characteristics**

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Input voltage	$V_{IH}$	-3.5	_	_	V	
	V <sub>IL</sub>	_	_	-1.2	V	
Input current (Gate non shut down)	I <sub>IH1</sub>	_	_	-100	μA	Vi = -8 V, V <sub>DS</sub> = 0
	I <sub>IH2</sub>	_	_	<b>–</b> 50	μA	$Vi = -3.5 \text{ V}, V_{DS} = 0$
	I <sub>IL</sub>	_	_	<b>–</b> 1	μA	Vi = -1.2 V, V <sub>DS</sub> = 0
Input current (Gate shut down)	I <sub>IH(sd)1</sub>	_	-0.8	_	mA	Vi = -8 V, V <sub>DS</sub> = 0
	I <sub>IH(sd)2</sub>	_	-0.35	_	mA	$Vi = -3.5 V, V_{DS} = 0$
Shut down temperature	Tsd	_	175	_	°C	Cannel temperature
Gate operation voltage	Vop	-3.5	_	-12	V	

# **Electrical Characteristics**

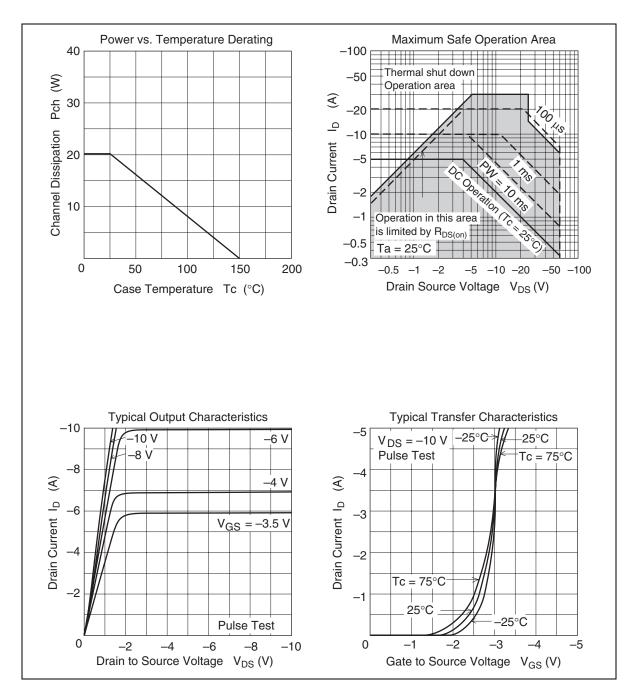
 $(Ta = 25^{\circ}C)$ 

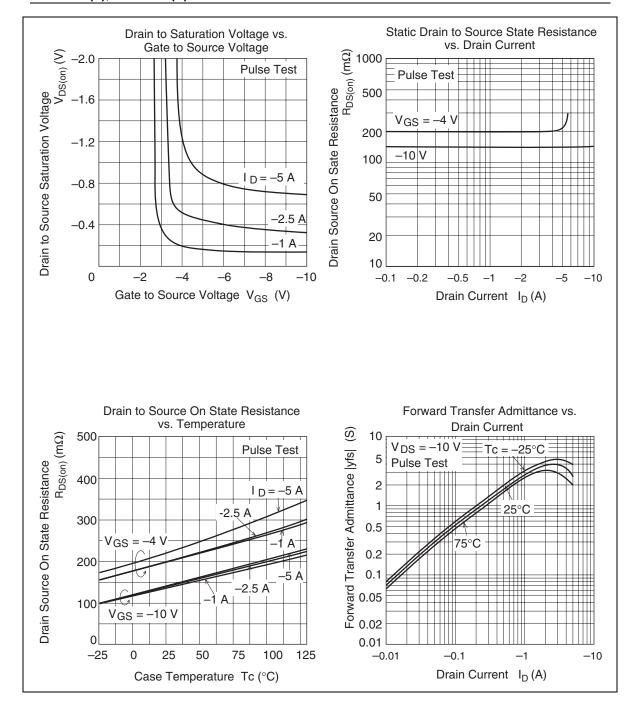
Item	Symbol	Vlin	Тур	Max	Unit	Test Conditions	
Drain current	I <sub>D1</sub>	4	_	_	Α	$V_{GS} = -3.5 \text{ V}, V_{DS} = -2 \text{ V}$	
Drain current	I <sub>D2</sub>	_	_	-10	mA	V <sub>GS</sub> = -1.2 V, V <sub>DS</sub> = -2 V	
Drain to source breakdown voltage	V <sub>(BR)DSS</sub>	-60	_	_	V	$I_D = -10 \text{ mA}, V_{GS} = 0$	
Gate to source breakdown voltage	V <sub>(BR)GSS</sub>	-16	_	_	V	$I_{G} = -800 \ \mu A, \ V_{DS} = 0$	
Gate to source breakdown voltage	V <sub>(BR)GSS</sub>	2.5	_	_	V	I <sub>G</sub> = 100 μA, V <sub>DS</sub> =0	
Gate to source leak current	I <sub>GSS1</sub>	_	_	-100	μΑ	V <sub>GS</sub> = -8 V, V <sub>DS</sub> =0	
	I <sub>GSS2</sub>	_	_	-50	μΑ	V <sub>GS</sub> = -3.5 V, V <sub>DS</sub> =0	
	I <sub>GSS3</sub>	_	_	<b>-1</b>	μΑ	V <sub>GS</sub> = -1.2 V, V <sub>DS</sub> =0	
	I <sub>GSS4</sub>	_	_	100	μΑ	V <sub>GS</sub> = 2.4 V, V <sub>DS</sub> =0	
Input current (shut down)	I <sub>GS(OP)1</sub>	_	-0.8	_	mA	V <sub>GS</sub> = -8 V, V <sub>DS</sub> =0	
	I <sub>GS(OP)2</sub>	_	-0.35	_	mA	V <sub>GS</sub> = -3.5 V, V <sub>DS</sub> =0	
Zero gate voltage drain current	I <sub>DSS</sub>	_	_	-10	μΑ	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0	
Gate to source cut off voltage	$V_{GS(off)}$	-1.1	_	-2.25	V	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -1 mA	
Forward transfer admittance	y <sub>fs</sub>	2	4	_	S	I <sub>D</sub> =–2.5 A, V <sub>DS</sub> =–10 V <sup>Note3</sup>	
Static drain to source on state resistance	R <sub>DS(on)</sub>	_	140	200	mΩ	$I_D = -2.5 \text{ A}, V_{GS} = -10 \text{ V}^{\text{Note3}}$	
Static drain to source on state resistance	R <sub>DS(on)</sub>		200	340	mΩ	$I_D = -2.5 \text{ A}, V_{GS} = -4 \text{ V}^{\text{Note3}}$	
Output capacitance	Coss	_	326	_	pF	$V_{DS} = -10 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$	
Turn-on delay time	t <sub>d(on)</sub>	_	2	_	μs	$V_{GS} = -5 \text{ V}, I_{D} = -2.5 \text{ A},$ $= R_{L} = 12 \Omega$	
Rise time	t <sub>r</sub>	_	7.6	_	μs		
Turn off delay time	t <sub>d(off)</sub>	_	3.2	_	μs		
Fall time	t <sub>f</sub>	_	3.2	_	μs		
Body-drain diode forward voltage	$V_{DF}$	_	-0.9	_	V	I <sub>F</sub> = -5A, V <sub>GS</sub> = 0	
Body-drain diode reverse recovery time	t <sub>rr</sub>	_	77	_	ns	$I_F = -5 \text{ A}, V_{GS} = 0$ diF/dt = 50 A/ $\mu$ s	
Over lord shut down operation time note4	t <sub>os1</sub>	_	8.4	_	ms	$V_{GS} = -5 \text{ V}, V_{DD} = -16 \text{ V}$	
	t <sub>os2</sub>	_	2.4	_	ms	$V_{GS} = -5 \text{ V}, V_{DD} = -24 \text{ V}$	

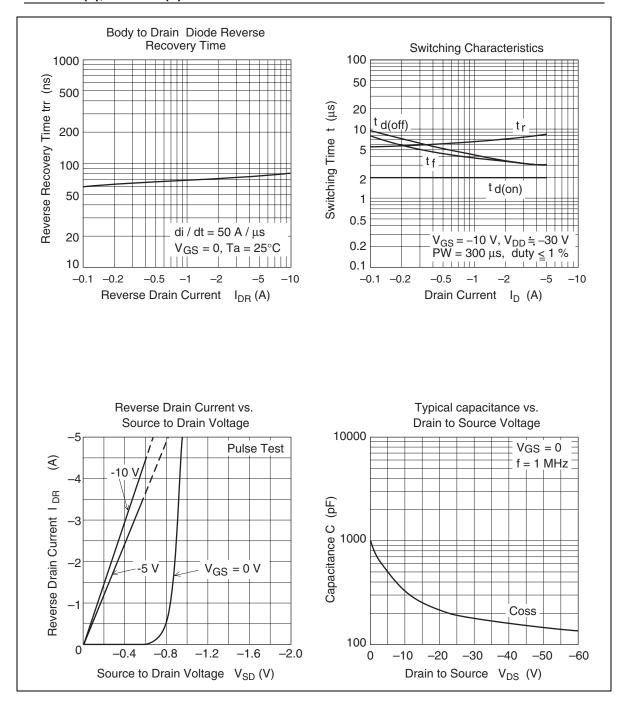
Notes: 3. Pulse test

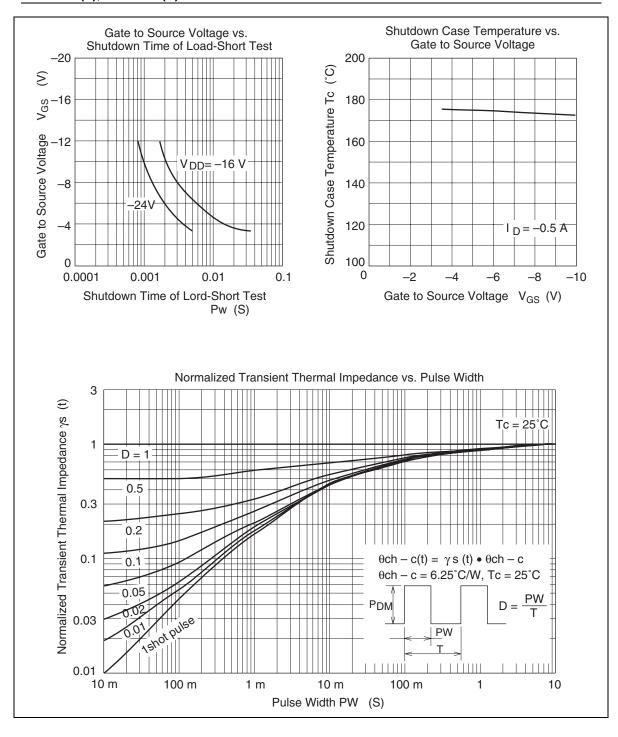
4. Including the junction temperature rise of the lorded condition

#### **Main Characteristics**

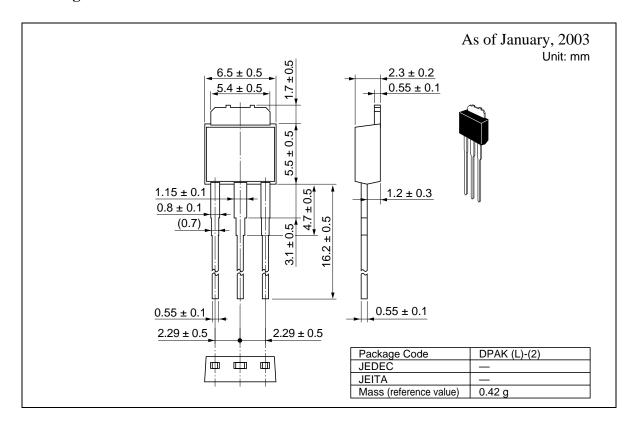


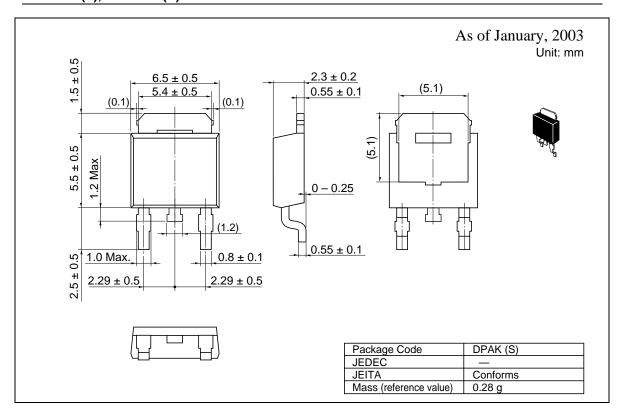






# **Package Dimensions**





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